

Industrial Internet Innovation Center (Shanghai) Co.,Ltd.**FCC/IC BT TEST REPORT**

PRODUCT	Wireless data POS System
BRAND	SUNMI
MODEL	T5820
FCC ID	2AH25T5820
IC	22621-T5820
APPLICANT	Shanghai Sunmi Technology Co.,Ltd.
ISSUE DATE	February 23, 2023
STANDARD(S)	FCC Part15, RSS-247 Issue 2, RSS-Gen Issue 5

Prepared by: *Tao Lingyan*Reviewed by: *Yang Fan*Approved by: *Zhang Min***CAUTION:**

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1. Summary of Test Report

1.1 Test Standard(s)

No.	Test Standard(s)	Title	Version
1	FCC Part15	FCC CFR 47, Part 15, Subpart C: 15.205 Restricted bands of operation; 15.209 Radiated emission limits, general requirements; 15.247 Operation within the bands 902-928MHz, 2400-2483.5MHz, and 5725-5850MHz.	2020
2	RSS-247 Issue 2	Digital Transmission Systems (DTSs), Frequency Hopping Systems (FHSs) and Licence-Exempt Local Area Network (LE-LAN) Devices	2017
3	RSS-Gen Issue 5	General Requirements for Compliance of Radio Apparatus	2021

1.2 Reference Documents

No.	Title	Title	Version
1	ANSI C63.10	American National Standard of Procedures for Compliance Testing of Unlicensed Wireless Devices	2013
2	KDB 558074	Guidance for Performing Compliance Measurements on Frequency Hopping Spread Spectrum systems (DSS) Operating Under §15.247	2019

1.3 Summary of Test Results

Measurement Items	Sub-clause of Part15C	Sub-clause of IC	Verdict
Maximum Peak Output Power	15.247(b)	RSS-247 5.4	Pass (NOTE 2)
20Db Occupied Bandwidth	15.247(a)	RSS-247 5.1	Pass (NOTE 2)
99% Occupied Bandwidth	15.247(a)	RSS-Gen 6.7	Pass (NOTE 2)
Band Edges Compliance	15.247 (d)	RSS-247 5.5	Pass (NOTE 2)
Time Of Occupancy (Dwell Time)	15.247(a)	RSS-247 5.1	Pass (NOTE 2)
Carrier Frequency Separation	15.247(a)	RSS-247 5.1	Pass (NOTE 2)
Number Of Hopping Channels	15.247(a)	RSS-247 5.1	Pass (NOTE 2)
Transmitter Spurious Emission- Conducted	15.247(d)	RSS-247 5.5	Pass (NOTE 2)
Transmitter Spurious Emission- Radiated	15.247,15.209,15.205	RSS-Gen 8.9,8.10	Pass
AC Powerline Conducted Emission	15.207	RSS-Gen 8.8	Pass (NOTE 2)

Note 1:

The T5820, manufactured by Shanghai Sunmi Technology Co.,Ltd. Is a variant product for testing.

This project is a variant project based on the original report I22I30121-SRD01-V00, original FCC ID 2AH25T5820C, IC 22621-T5820C. T5820 the detail differences description as below:

Type of Certification	Configuration type	NFC function	Cradle(Pogo PIN)	AC adapter	Panel dimension
Parent	High configuration	Yes	Yes	input : 5V/2A	5.0 inch
Variant (Based on Parent)	Basic configuration	No	No	input : 5V/1A	4.95 inch

The above differences do not affect the RF performance, The report data was derived from the original reported and RSE tested worst mode is placed in the report. Verify the power of the variant product, and the test results meet the limit requirements.

Industrial Internet Innovation Center (Shanghai) Co., Ltd. Only performed test cases which identified with Pass/Fail/Inc result in section 1.

Industrial Internet Innovation Center (Shanghai) Co., Ltd. Has verified that the compliance of the tested device specified in section 4 of this test report is successfully evaluated according to the procedure and test methods as defined in type certification requirement listed in section 1.3 of this test report.

Note 2:

The test verdict of this item come from the original report.

- All the test data for each data were verified, but only the worst case was reported.
- The DC and low frequency voltages' measurement uncertainty is $\pm 2\%$.

1.4 Data Provided by Applicant

No.	Item(s)	Data
1	Antenna gain of EUT	2.27 dBi

Note: The data of 1.4 is provided by the customer may affect the validity of the test results in this report, and the impact and consequences of this shall be undertaken by the customer.

2. General Information of The Laboratory

2.1 Testing Laboratory

Lab Name	Industrial Internet Innovation Center (Shanghai) Co.,Ltd.
Address	Building 4, No. 766, Jingang Road, Pudong, Shanghai, China
Telephone	021-68866880
FCC Registration No.	958356
FCC Designation No.	CN1177
IC Designation No.	10766A

2.2 Laboratory Environmental Requirements

Temperature	15°C~35°C
Relative Humidity	25%RH~75%RH
Atmospheric Pressure	101kPa

2.3 Project Information

Project Manager	Gao Hongning
Test Date	October 20, 2022 to January 19, 2023

3. General Information of The Customer

3.1 Applicant

Company	Shanghai Sunmi Technology Co.,Ltd.
Address	Room 505, No.388, Song Hu Road, Yang Pu District, Shanghai, China
Telephone	13510126210

3.2 Manufacturer

Company	Shanghai Sunmi Technology Co.,Ltd.
Address	Room 505, No.388, Song Hu Road, Yang Pu District, Shanghai, China

4. General Information of The Product

4.1 Product Description for Equipment under Test (EUT)

Product	Wireless data POS System
Model	T5820
Date of Receipt	S02aa:October 20,2022
EUT ID*	S02aa
SN/IMEI	S02aa: 860450060011182 860450060011190
Supported Radio Technology and Bands	GSM850/GSM900/DCS1800/PCS1900 WCDMA Band I/II/IV/V/VIII LTE Band 1/2/3/4/5/7/12/17/28/38/41 WLAN 802.11 b/g/n WLAN 802.11 a/n/ac BT5.1 BR/EDR, BLE GPS/Glonass/BDS
HVIN	T5820
Hardware Version	V01
Software Version	XQT530_V004_20220923
FCC ID	2AH25T5820
IC	22621-T5820
NOTE: EUT ID is the internal identification code of the laboratory.	

4.2 Description for Auxiliary Equipment (AE)

AE ID*	Description	Model	SN/Remark
AE1	RF Cable	N/A	N/A
NOTE: AE ID is the internal identification code of the laboratory.			

4.3 Additional Information

Bluetooth Frequency	2402MHz-2480MHz
Bluetooth Channel	Ch0-78
Bluetooth Modulation	GFSK; $\pi/4$ DQPSK; 8DPSK

5. Test Configuration Information

5.1 Laboratory Environmental Conditions

41.66.3 Permanent Facilities

Relative Humidity	Min. = 45 %, Max. = 55 %		
Atmospheric Pressure	101kPa		
Temperature	Normal	Minimum	Maximum
	25℃	0℃	45℃
Working Voltage of EUT	Normal	Minimum	Maximum
	7.2V	6.8V	8.4V

5.2 Test Equipments Utilized

5.2.1 Conducted Test System

No.	Name	Model	S/N	Manufacturer	Cal. Date	Cal. Interval
1	Programmable Power Supply	Keithley 2303	4039070	Starpoint	July 12, 2022	1 Year
2	Vector Signal Generator	SMBV100A	257904	R&S	February 21, 2022	1 Year
3	Temperature box	B-TF-107C	BTF107C-201804107	Boyi	June 30, 2022	1 Year
4	Spectrum Analyzer	FSQ40	200063	R&S	October 19, 2022	1 year
5	USB Wideband Power Sensor	U2021XA	MY56410009	Keysight	February 21, 2022	1 Year
6	Simultaneous Sampling DQA	U2531A	TW56183514	Agilent	March 02, 2022	1 Year
7	Vector Signal Generator	SMU200A	104684	R&S	August 23, 2022	1 Year
8	Wireless communication comprehensive tester	CMW270	100919	R&S	August 22, 2022	1 Year
9	Eagle Test Software	Eagle V3.3	N/A	ECIT	N/A	N/A

10	Talent Microwave Band Rejection Filter	Filter	191016001	N/A	N/A	N/A
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5.2.2 Radiated Emission Test System

No.	Name	Model	S/N	Manufacturer	Cal. Date	Cal. Interval
1	Universal Radio Communication Tester	CMU200	123123	R&S	October 17,2022	1Year
2	Universal Radio Communication Tester	CMW500	104178	R&S	October 17,2022	1Year
3	EMI Test Receiver	ESU40	100307	R&S	February 23, 2022	1 Year
4	TRILOG Broadband Antenna	VULB9163	VULB9163-515	Schwarzbeck	March 11, 2022	1 Year
5	Double- ridged Waveguide Antenna	ETS-3117	00135890	ETS	March 9, 2022	2 Years
6	2-Line V-Network	ENV216	101380	R&S	February 21, 2022	1 Year
7	EMI Test Software	EMC32 V9.15.00	N/A	R&S	N/A	N/A

5.2.3 Test Environment

Shielding Room1 (6.0 meters×3.0 meters×2.7 meters) did not exceed following limits along the conducted RF performance testing:

Temperature	Min. = 15 °C, Max. = 35 °C
Relative humidity	Min. = 20 %, Max. = 75 %
Shielding effectiveness	> 100 Db
Ground system resistance	< 0.5 Ω
Temperature	Min. = 15 °C, Max. = 35 °C

Control room did not exceed following limits along the EMC testing:

Temperature	Min. = 15 °C, Max. = 35 °C
Relative humidity	Min. =30 %, Max. = 60 %
Shielding effectiveness	> 100 Db
Electrical insulation	> 10 kΩ
Ground system resistance	< 0.5 Ω

Fully-anechoic chamber1 (6.9 meters×10.9 meters×5.4 meters) did not exceed following limits along the

EMC testing:

Temperature	Min. = 15 °C, Max. = 35 °C
Relative humidity	Min. = 25 %, Max. = 75 %
Shielding effectiveness	> 100 Db
Electrical insulation	> 10 kΩ
Ground system resistance	< 0.5 Ω
VSWR	Between 0 and 6 Db, from 1GHz to 18GHz
Site Attenuation Deviation	Between -4 and 4 Db, 30MHz to 1GHz

5.3 Measurement Uncertainty

Measurement Items	Range	Confidence Level	Calculated Uncertainty
Peak Output Power-Conducted	2402MHz-2480MHz	95%	0.544Db
Frequency Band Edges-Conducted	2402MHz-2480MHz	95%	0.544Db
Conducted Emission	9KHz-30MHz	95%	0.89Db
Conducted Emission	30MHz-2GHz	95%	0.90Db
Conducted Emission	2GHz-3.6GHz	95%	0.88Db
Conducted Emission	3.6GHz-8GHz	95%	0.96Db
Conducted Emission	8GHz-20GHz	95%	0.94Db
Conducted Emission	20GHz-22GHz	95%	0.88Db
Conducted Emission	22GHz-26GHz	95%	0.86Db
Transmitter Spurious Emission-Radiated	9KHz-30MHz	95%	5.66Db
Transmitter Spurious Emission-Radiated	30MHz-1000MHz	95%	4.98Db
Transmitter Spurious Emission-Radiated	1000MHz -18000MHz	95%	5.06Db
Transmitter Spurious Emission-Radiated	18000MHz -40000MHz	95%	5.20Db
Dwell Time	2402MHz-2480MHz	95%	0.218ms
20Db Bandwidth	2402MHz-2480MHz	95%	62.04Hz
AC Power line Conducted Emission	0.15MHz-30MHz	95%	3.66 Db

6. Test Results

6.1 Peak Output Power-Conducted

6.1.1 Measurement Limit

Standard	Limit (dBm)	EIRP Limit (dBm)
FCC 47 Part 15.247(b)(3)	<30	<36
RSS-247 5.4(d)	<30	<36

6.1.2 Test Condition

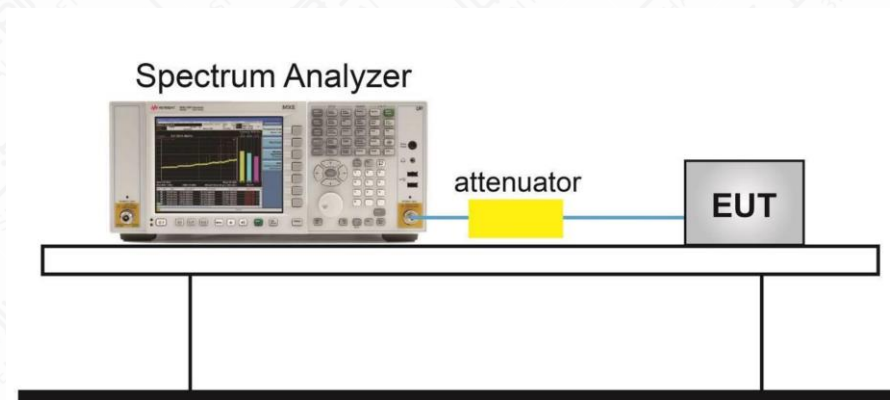
Hopping Mode	RBW	VBW	Span	SweepTime
Hopping OFF	3MHz	10MHz	9MHz	Auto

6.1.3 Test Procedure

The measurement is according to ANSI C63.10 clause 7.8.5.

1. The output power of EUT was connected to the spectrum analyzer and CMW 270 by cable and divide. The path loss was compensated to the results for each measurement.
2. Enable EUT transmitter maximum power continuously.
3. Measure the conducted output power and record the results it

6.1.4 Test setup



Original Measurement Results

Modulation type	Channel	Power(dBm)	Gain(dBi)	EIRP(dBm)
GFSK DH5	Ch 0	9.37	2.27	11.64
	Ch 19	8.63	2.27	10.9
	Ch 39	9.93	2.27	12.2
$\pi/4$ DQPSK	Ch 0	8.67	2.27	10.94
	Ch 19	8.55	2.27	10.82
	Ch 39	9.22	2.27	11.49
8DPSK	Ch 0	8.64	2.27	10.91
	Ch 19	8.52	2.27	10.79
	Ch 39	9.24	2.27	11.51

Verified Power

Modulation type	Channel	Power(dBm)	Gain(dBi)	EIRP(dBm)
GFSK DH5	Ch 0	8.67	2.27	10.94
	Ch 19	7.8	2.27	10.07
	Ch 39	7.22	2.27	9.49
$\pi/4$ DQPSK	Ch 0	8.11	2.27	10.38
	Ch 19	8.09	2.27	10.36
	Ch 39	8.56	2.27	10.83
8DPSK	Ch 0	8.05	2.27	10.32
	Ch 19	8.01	2.27	10.28
	Ch 39	8.55	2.27	10.82

NOTE:

The verified power is still in the tune-up power range and meets the requirements of KDB484596 D01 data reference. The power listed in the original certificate still applies to this case.

6.2 Radiated Emission

6.2.1 Measurement Limit

Standard	Limit
FCC 47 CFR Part 15.247, 15.205, 15.209	20Db below peak output power
RSS-Gen 8.9,8.10	20Db below peak output power

In addition, radiated emissions which fall in the restricted bands, as defined in 15.205(a), must also comply with the radiated emission limits specified in 15.209(a) (see 15.205(c)).

Limit in restricted band

Frequency of emission (MHz)	Field strength (Mv/m)	Field strength (dBuV/m)
0.009~0.49	2400/F (kHz)	129-94
0.49~1.705	24000/F (kHz)	74-63
1.705~30	30	70
30~88	100	40
88~216	150	43.5
216~960	200	46
Above 960	500	54

6.2.2 Test Method

Portable, small, lightweight, or modular devices that may be handheld, worn on the body, or placed on a table during operation shall be positioned on a non-conducting platform, the top of which is 80 cm above the reference ground plane. The preferred area occupied by the EUT arrangement is 1 m by 1.5 m. For emissions testing at or below 1 GHz, the table height shall be 80 cm above the reference ground plane. For emission measurements above 1 GHz, the table height shall be 1.5 m. but it may be larger or smaller to accommodate various sized EUTs. For testing purposes, ceiling- and wall-mounted devices also shall be positioned on a tabletop (see also ANSI C63.10-2013 section 6.3.4 and 6.3.5). In making any tests involving handheld, body-worn, or ceiling-mounted equipment, it is essential to recognize that the measured levels may be dependent on the orientation (attitude) of the three orthogonal axes of the EUT. Thus, exploratory tests as specified in 8.3.1 shall be carried out for various axes orientations to determine the attitude having maximum or near-maximum emission level.

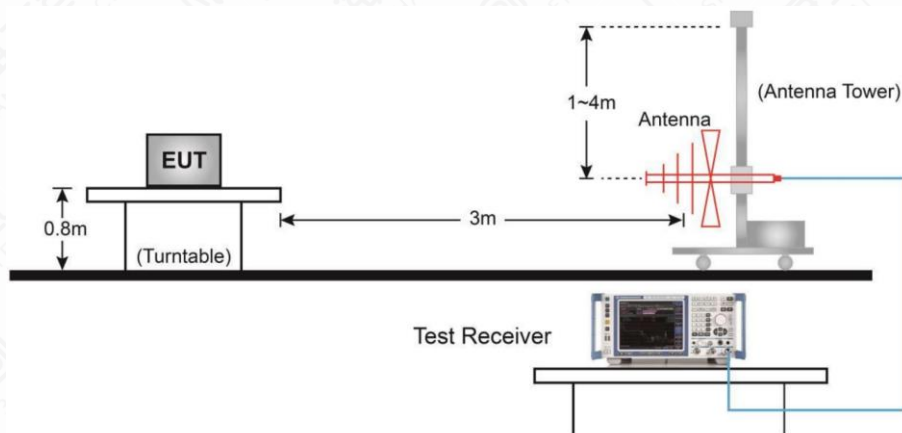
The EUT was placed on a non-conductive table. The measurement antenna was placed at a distance of 3 meters from the EUT. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations.

Frequency of emission	RBW/VBW	Sweep Time (s)
0.009~30	9KHz/30KHz	Auto
30~1000	100KHz/300KHz	5
1000~4000	1MHz/3MHz	15
4000~18000	1MHz/3MHz	40

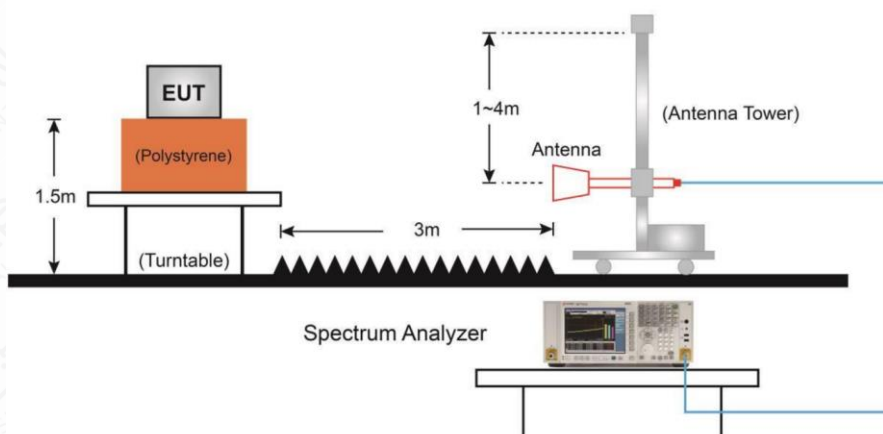
18000~26500	1MHz/3MHz	20
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6.2.3 Test Setup

Below 1GHz Test Setup



Above 1GHz Test Setup



Measurement Results

A "reference path loss" is established and Ar_{pi} is the attenuation of "reference path loss", and including the gain of receive antenna, the gain of the preamplifier, the cable loss.

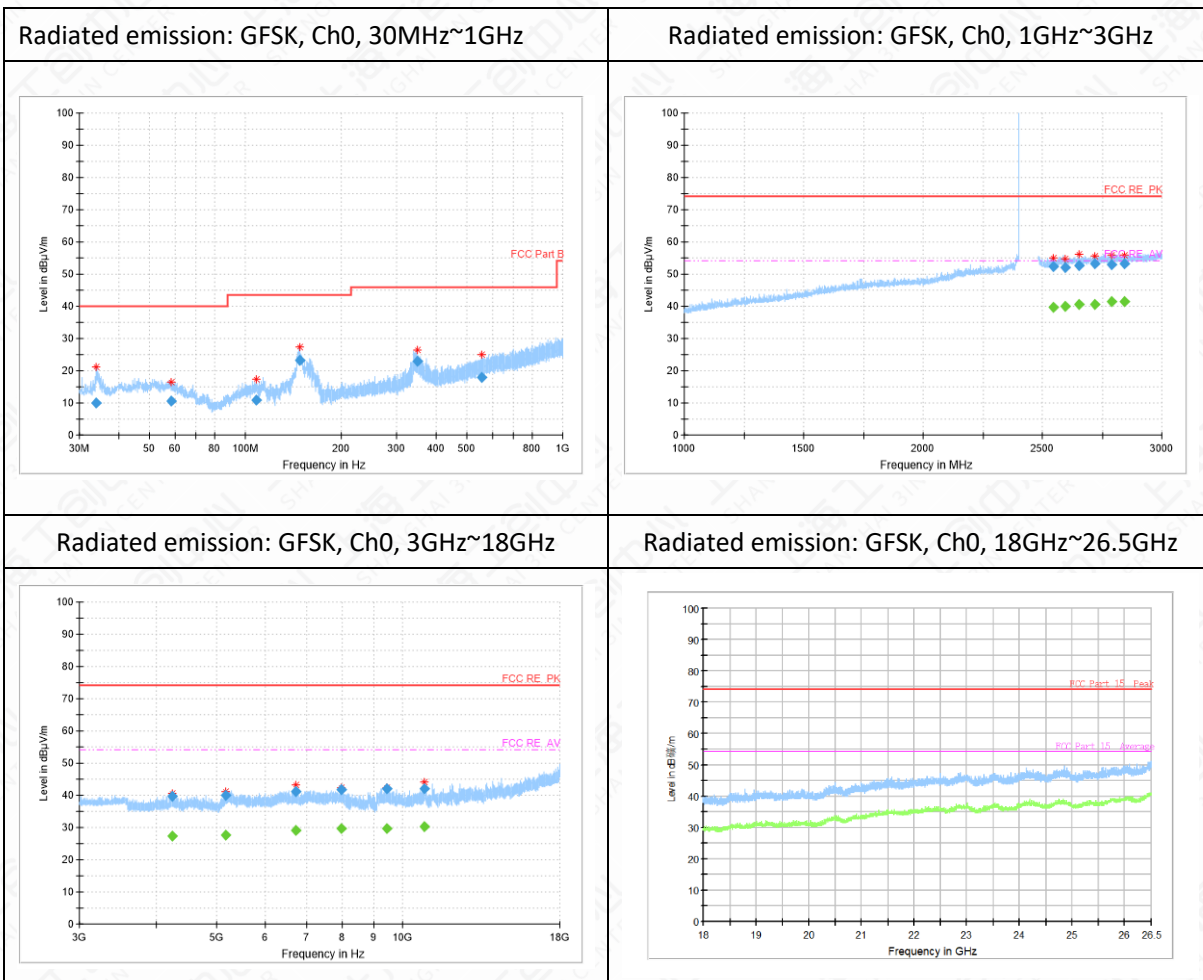
The measurement results are obtained as described below:

$Ar_{pi} = \text{Cable loss} + \text{Antenna Factor} - \text{Preamplifier gain}$

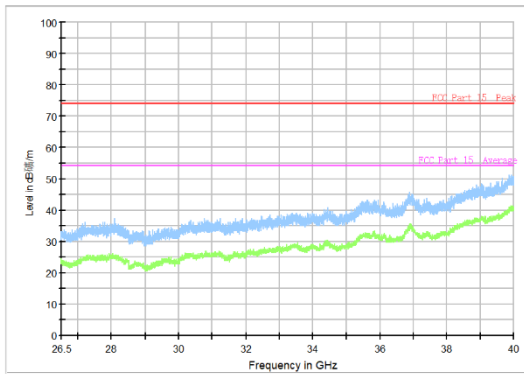
$\text{Result} = P_{mea} + Ar_{pi}$

The test data below 30MHz is more than 20Db lower than the limit value, so it is not provided in the report.

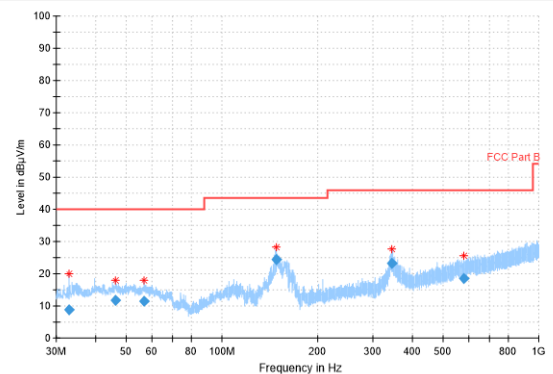
GFSK



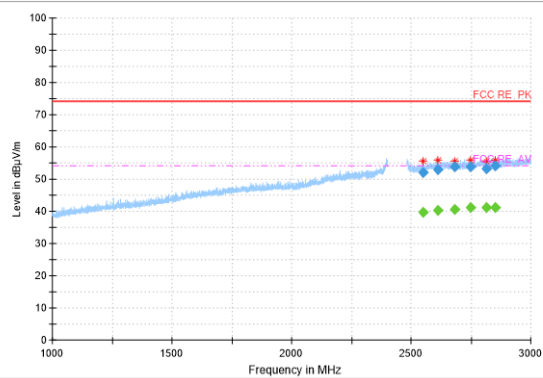
Radiated emission: GFSK, Ch0, 26.5GHz~40GHz



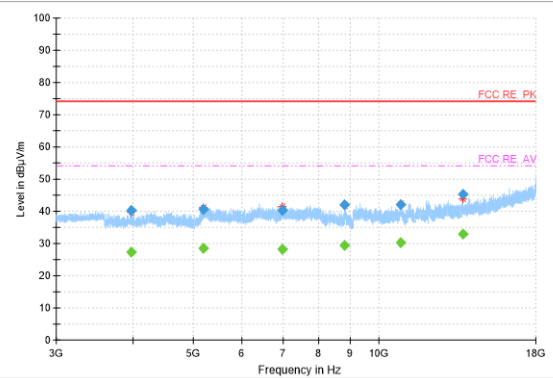
Radiated emission: GFSK, Ch78, 30MHz~1GHz



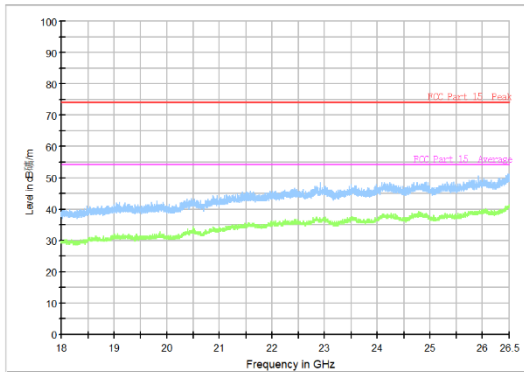
Radiated emission: GFSK, Ch78, 1GHz~3GHz



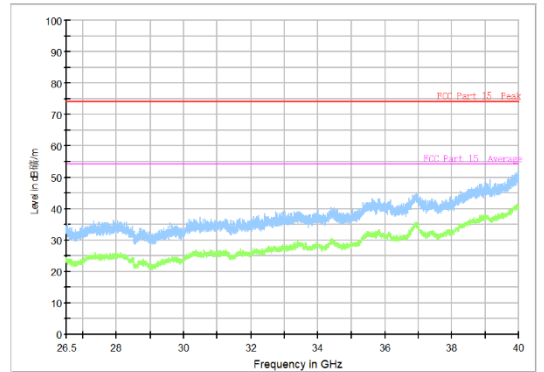
Radiated emission: GFSK, Ch78, 3GHz~18GHz



Radiated emission: GFSK, Ch78, 18GHz~26.5GHz



Radiated emission: GFSK, Ch78, 26.5GHz~40GHz



Note:

1. The out-of- limit signal in the picture is the main frequency signal.
2. Only the worst mode data is provided.

GFSK Ch0 30MHz-1GHz

Frequency (MHz)	Result (dBμV/m)	Arpl (Db)	Pmea (dBμV/m)	Polarity
34.0	9.9	-14.1	24	H
58.3	10.65	-12.2	22.85	H
108.0	10.78	-13.2	23.98	H

148.4	23.14	-17.1	40.24	H
347.3	22.97	-9.4	32.37	H
557.2	18.04	-4.4	22.44	H

GFSK Ch0 1GHz-3GHz

Frequency (MHz)	Result (dBμV/m)	Arpl (Db)	Pmea (dBμV/m)	Polarity
2544.1	52.24	15	37.24	H
2596.5	52.01	15.5	36.51	H
2652.8	52.57	15.9	36.67	V
2719.9	53.1	16	37.1	V
2790.8	52.93	16.5	36.43	H
2844.1	53.22	16.6	36.62	H

GFSK Ch0 3GHz-18GHz

Frequency (MHz)	Result (dBμV/m)	Arpl (Db)	Pmea (dBμV/m)	Polarity
4238.4	39.73	-5.4	45.13	V
5178.8	39.88	-1	40.88	V
6724.5	41.28	-2.4	43.68	V
7957.0	41.76	-1.1	42.86	V
9429.1	41.92	-0.2	42.12	H
10859.1	42.17	1.1	41.07	V

GFSK Ch78 30MHz-1GHz

Frequency (MHz)	Result (dBμV/m)	Arpl (Db)	Pmea (dBμV/m)	Polarity
33.0	8.83	-14.2	23.03	H
46.1	11.65	-12.3	23.95	H
56.9	11.36	-12.2	23.56	H
148.4	24.27	-17.1	41.37	H
344.8	23.26	-9.5	32.76	H
580.0	18.59	-3.9	22.49	H

GFSK Ch78 1GHz-3GHz

Frequency (MHz)	Result (dBμV/m)	Arpl (Db)	Pmea (dBμV/m)	Polarity
2550.8	52.17	15.1	37.07	H
2610.2	52.97	15.6	37.37	H
2682.8	53.88	15.9	37.98	H
2749.5	53.81	16.2	37.61	H
2812.7	53.26	16.6	36.66	H
2853.0	54.14	16.7	37.44	H

GFSK Ch78 1GHz-3GHz (Average)

Frequency (MHz)	Result (dB μ V/m)	Arpl (Db)	Pmea (dB μ V/m)	Polarity
2853.0	41.21	16.7	24.51	H

GFSK Ch78 3GHz-18GHz

Frequency (MHz)	Result (dB μ V/m)	Arpl (Db)	Pmea (dB μ V/m)	Polarity
3969.0	40.2	-5.6	45.8	V
5190.1	40.47	-1	41.47	V
6978.2	40.42	-2.3	42.72	H
8799.1	42.05	-1.5	43.55	H
10843.7	42.2	1.1	41.1	V
13677.7	45.41	4	41.41	H

Annex A: Revised History

Version	Revised Content
V00	Initial
V01	Update 1.3 section note
V02	Update 1.3 section note
V03	Add test results of the power

Annex B: Accreditation Certificate



Accredited Laboratory

A2LA has accredited

INDUSTRIAL INTERNET INNOVATION CENTER (SHANGHAI) CO., LTD.

Shanghai, People's Republic of China

for technical competence in the field of

Electrical Testing

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 General requirements for the competence of testing and calibration laboratories. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).



Presented this 12th day of April 2021.

Vice President, Accreditation Services
For the Accreditation Council
Certificate Number 3682.01
Valid to February 28, 2023

For the tests to which this accreditation applies, please refer to the laboratory's Electrical Scope of Accreditation.

END OF REPORT